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PATENT

ATTY. DKT.: 28951.1166

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Serial No.: 10/611,433

Confirmation No.: 1440

In re Application of:

Akihiro SUZUKI et al.

Group Art Unit: 2621

Filed: July 2, 2003

For: DATA SLICER, DATA SLICING METHOD, AND  
AMPLITUDE EVALUATION VALUE SETTING METHOD

INFORMATION DISCLOSURE STATEMENT  
PURSUANT TO 37 CFR 1.97(e)(1)

Customer Window  
U.S. Patent & Trademark Office  
Randolph Building  
401 Dulany Street  
Alexandria, VA 22314

Sir:

Pursuant to 37 CFR 1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached Form PTO-1449, which include the references newly cited in the attached European Search Report dated August 5, 2005 in a counterpart European patent application. A copy of the cited foreign document is enclosed.

The above information is presented so that the Patent and Trademark Office may, in the first instance, determine any materiality thereof to the claimed invention. See 37 CFR 1.104(a) and 1.106(b) concerning the PTO duty to consider and use any such information. It is respectfully requested that this information be expressly considered during the prosecution of

this application, and that this reference be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

Since the documents cited herein were cited in a counterpart foreign application not more than three months prior to the filing of the present Information Disclosure Statement, no fee is due.

Respectfully Submitted,

STEPTOE & JOHNSON LLP

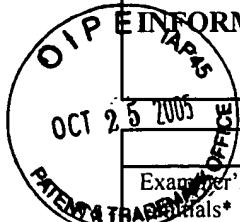


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FORM 1449 (S&J Version)	Docket No.: 28951.1166
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>	Applicant: A. SUZUKI et al.
	Application No.: 10/611,433
	Filing Date: 07/02/2003
	Examiner: _____
	Group Art Unit: 2621



## U.S. PATENT DOCUMENTS

## FOREIGN PATENT DOCUMENTS

## OTHER DOCUMENTS

Examiner's Initials*	Include author, title of article, title of item (book, journal, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

Examiner's Signature		Date Considered	
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.